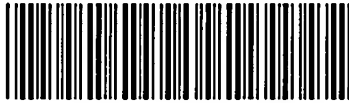


**Search Notes**

Application/Control No.

10/082,081

Examiner

Dave Czekaj

Applicant(s)/Patent under  
Reexamination

LEE, CHULHEE

Art Unit

2621

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated Previous Search	9/12/2006	DC